

**Search Notes**

Application No.

09/869,274

Examiner

W. David Coleman

Applicant(s)

NISHIMURA ET AL.

Art Unit

2823

**SEARCHED**

Class	Subclass	Date	Examiner
257	48 50 E21.521 E21.524	3/23/2004	WDC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	48	3/23/2004	WDC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST 1.4.1 Applicants form test pads and solder bumps that are not coupled together for an IC.	3/23/2004	WDC